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Understanding [Embedded - Microprocessors](#)

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

Applications of [Embedded - Microprocessors](#)

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

Details

Product Status	Active
Core Processor	-
Number of Cores/Bus Width	-
Speed	-
Co-Processors/DSP	-
RAM Controllers	-
Graphics Acceleration	-
Display & Interface Controllers	-
Ethernet	-
SATA	-
USB	-
Voltage - I/O	-
Operating Temperature	-
Security Features	-
Package / Case	-
Supplier Device Package	-
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=mpc8323cvraddca

1.3 Security Engine

The security engine is optimized to handle all the algorithms associated with IPSec, IEEE 802.11i™ standard, and iSCSI. The security engine contains one crypto-channel, a controller, and a set of crypto execution units (EUs). The execution units are:

- Data encryption standard execution unit (DEU), supporting DES and 3DES
- Advanced encryption standard unit (AESU), supporting AES
- Message digest execution unit (MDEU), supporting MD5, SHA1, SHA-256, and HMAC with any algorithm
- One crypto-channel supporting multi-command descriptor chains

1.4 DDR Memory Controller

The MPC8323E DDR1/DDR2 memory controller includes the following features:

- Single 32-bit interface supporting both DDR1 and DDR2 SDRAM
- Support for up to 266-MHz data rate
- Support for two ×16 devices
- Support for up to 16 simultaneous open pages
- Supports auto refresh
- On-the-fly power management using CKE
- 1.8-/2.5-V SSTL2 compatible I/O
- Support for 1 chip select only
- FCRAM, ECC, hardware/software calibration, bit deskew, QIN stage, or atomic logic are not supported.

1.5 PCI Controller

The MPC8323E PCI controller includes the following features:

- *PCI Specification Revision 2.3* compatible
- Single 32-bit data PCI interface operates up to 66 MHz
- PCI 3.3-V compatible (not 5-V compatible)
- Support for host and agent modes
- On-chip arbitration, supporting three external masters on PCI
- Selectable hardware-enforced coherency

1.6 Programmable Interrupt Controller (PIC)

The programmable interrupt controller (PIC) implements the necessary functions to provide a flexible solution for general-purpose interrupt control. The PIC programming model is compatible with the MPC8260 interrupt controller, and it supports 8 external and 35 internal discrete interrupt sources. Interrupts can also be redirected to an external interrupt controller.

Table 6. Estimated Typical I/O Power Dissipation (continued)

Local bus I/O load = 25 pF 1 pair of clocks	66 MHz, 32 bits	—	—	0.12	W	—
PCI I/O load = 30 pF	66 MHz, 32 bits	—	—	0.057	W	—
QUICC Engine block and other I/Os	UTOPIA 8-bit 31 PHYs	—	—	0.041	W	Multiply by number of interfaces used.
	TDM serial	—	—	0.001	W	
	TDM nibble	—	—	0.004	W	
	HDLC/TRAN serial	—	—	0.003	W	
	HDLC/TRAN nibble	—	—	0.025	W	
	DUART	—	—	0.017	W	
	MIIs	—	—	0.009	W	
	RMII	—	—	0.009	W	
	Ethernet management	—	—	0.002	W	
	USB	—	—	0.001	W	
	SPI	—	—	0.001	W	
	Timer output	—	—	0.002	W	

NOTE

AV_{DDn} (1.0 V) is estimated to consume 0.05 W (under normal operating conditions and ambient temperature).

4 Clock Input Timing

This section provides the clock input DC and AC electrical characteristics for the MPC8323E.

NOTE

The rise/fall time on QUICC Engine input pins should not exceed 5 ns. This should be enforced especially on clock signals. Rise time refers to signal transitions from 10% to 90% of VCC; fall time refers to transitions from 90% to 10% of VCC.

4.1 DC Electrical Characteristics

Table 7 provides the clock input (CLKIN/PCI_SYNC_IN) DC timing specifications for the MPC8323E.

Table 7. CLKIN DC Electrical Characteristics

Parameter	Condition	Symbol	Min	Max	Unit
Input high voltage	—	V_{IH}	2.7	$OV_{DD} + 0.3$	V
Input low voltage	—	V_{IL}	-0.3	0.4	V

6.2 DDR1 and DDR2 SDRAM AC Electrical Characteristics

This section provides the AC electrical characteristics for the DDR1 and DDR2 SDRAM interface.

6.2.1 DDR1 and DDR2 SDRAM Input AC Timing Specifications

Table 16 provides the input AC timing specifications for the DDR2 SDRAM ($Dn_GV_{DD}(typ) = 1.8\text{ V}$).

Table 16. DDR2 SDRAM Input AC Timing Specifications for 1.8-V Interface

At recommended operating conditions with Dn_GV_{DD} of $1.8 \pm 5\%$.

Parameter	Symbol	Min	Max	Unit	Notes
AC input low voltage	V_{IL}	—	$MVREFn_{REF} - 0.25$	V	—
AC input high voltage	V_{IH}	$MVREFn_{REF} + 0.25$	—	V	—

Table 17 provides the input AC timing specifications for the DDR1 SDRAM ($Dn_GV_{DD}(typ) = 2.5\text{ V}$).

Table 17. DDR1 SDRAM Input AC Timing Specifications for 2.5 V Interface

At recommended operating conditions with Dn_GV_{DD} of $2.5 \pm 5\%$.

Parameter	Symbol	Min	Max	Unit	Notes
AC input low voltage	V_{IL}	—	$MVREFn_{REF} - 0.31$	V	—
AC input high voltage	V_{IH}	$MVREFn_{REF} + 0.31$	—	V	—

Table 18 provides the input AC timing specifications for the DDR1 and DDR2 SDRAM interface.

Table 18. DDR1 and DDR2 SDRAM Input AC Timing Specifications

At recommended operating conditions with Dn_GV_{DD} of $(1.8\text{ or }2.5\text{ V}) \pm 5\%$.

Parameter	Symbol	Min	Max	Unit	Notes
Controller skew for MDQS—MDQ/MDM	t_{CISKEW}			ps	1, 2
	266 MHz	-750	750		
	200 MHz	-1250	1250		

Notes:

- t_{CISKEW} represents the total amount of skew consumed by the controller between MDQS[n] and any corresponding bit that is captured with MDQS[n]. This should be subtracted from the total timing budget.
- The amount of skew that can be tolerated from MDQS to a corresponding MDQ signal is called t_{DISKEW} . This can be determined by the following equation: $t_{DISKEW} = \pm(T/4 - \text{abs}(t_{CISKEW}))$ where T is the clock period and $\text{abs}(t_{CISKEW})$ is the absolute value of t_{CISKEW} .

7 DUART

This section describes the DC and AC electrical specifications for the DUART interface of the MPC8323E.

7.1 DUART DC Electrical Characteristics

Table 20 provides the DC electrical characteristics for the DUART interface of the MPC8323E.

Table 20. DUART DC Electrical Characteristics

Parameter	Symbol	Min	Max	Unit
High-level input voltage	V_{IH}	2	$OV_{DD} + 0.3$	V
Low-level input voltage OV_{DD}	V_{IL}	-0.3	0.8	V
High-level output voltage, $I_{OH} = -100 \mu A$	V_{OH}	$OV_{DD} - 0.2$	—	V
Low-level output voltage, $I_{OL} = 100 \mu A$	V_{OL}	—	0.2	V
Input current ($0 V \leq V_{IN} \leq OV_{DD}$) ¹	I_{IN}	—	± 5	μA

Note:

- Note that the symbol V_{IN} , in this case, represents the OV_{IN} symbol referenced in Table 1 and Table 2.

7.2 DUART AC Electrical Specifications

Table 21 provides the AC timing parameters for the DUART interface of the MPC8323E.

Table 21. DUART AC Timing Specifications

Parameter	Value	Unit	Notes
Minimum baud rate	256	baud	
Maximum baud rate	> 1,000,000	baud	1
Oversample rate	16	—	2

Notes:

- Actual attainable baud rate is limited by the latency of interrupt processing.
- The middle of a start bit is detected as the 8th sampled 0 after the 1-to-0 transition of the start bit. Subsequent bit values are sampled each 16th sample.

8 Ethernet and MII Management

This section provides the AC and DC electrical characteristics for Ethernet and MII management.

8.1 Ethernet Controller (10/100 Mbps)—MII/RMII Electrical Characteristics

The electrical characteristics specified here apply to all MII (media independent interface) and RMII (reduced media independent interface), except MDIO (management data input/output) and MDC

8.2.2.1 RMI Transmit AC Timing Specifications

Table 23 provides the RMI transmit AC timing specifications.

Table 25. RMI Transmit AC Timing Specifications

At recommended operating conditions with OV_{DD} of $3.3\text{ V} \pm 10\%$.

Parameter/Condition	Symbol ¹	Min	Typical	Max	Unit
REF_CLK clock	t_{RMX}	—	20	—	ns
REF_CLK duty cycle	t_{RMXH}/t_{RMX}	35	—	65	%
REF_CLK to RMI data TXD[1:0], TX_EN delay	$t_{RMTKHDX}$	2	—	10	ns
REF_CLK data clock rise $V_{IL}(\text{min})$ to $V_{IH}(\text{max})$	t_{RMXR}	1.0	—	4.0	ns
REF_CLK data clock fall $V_{IH}(\text{max})$ to $V_{IL}(\text{min})$	t_{RMXF}	1.0	—	4.0	ns

Note:

- The symbols used for timing specifications follow the pattern of $t_{(\text{first three letters of functional block})(\text{signal})(\text{state})(\text{reference})(\text{state})}$ for inputs and $t_{(\text{first two letters of functional block})(\text{reference})(\text{state})(\text{signal})(\text{state})}$ for outputs. For example, $t_{RMTKHDX}$ symbolizes RMI transmit timing (RMT) for the time t_{RMX} clock reference (K) going high (H) until data outputs (D) are invalid (X). Note that, in general, the clock reference symbol representation is based on two to three letters representing the clock of a particular functional. For example, the subscript of t_{RMX} represents the RMI(RM) reference (X) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).

Figure 10 shows the RMI transmit AC timing diagram.

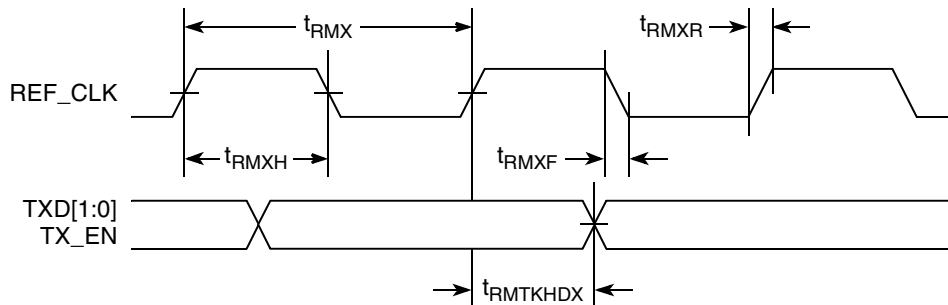


Figure 10. RMI Transmit AC Timing Diagram

8.2.2.2 RMI Receive AC Timing Specifications

Table 24 provides the RMI receive AC timing specifications.

Table 26. RMI Receive AC Timing Specifications

At recommended operating conditions with OV_{DD} of $3.3\text{ V} \pm 10\%$.

Parameter/Condition	Symbol ¹	Min	Typical	Max	Unit
REF_CLK clock period	t_{RMX}	—	20	—	ns
REF_CLK duty cycle	t_{RMXH}/t_{RMX}	35	—	65	%
RXD[1:0], CRS_DV, RX_ER setup time to REF_CLK	$t_{RMRDVKH}$	4.0	—	—	ns
RXD[1:0], CRS_DV, RX_ER hold time to REF_CLK	$t_{RMRDXKH}$	2.0	—	—	ns
REF_CLK clock rise $V_{IL}(\text{min})$ to $V_{IH}(\text{max})$	t_{RMXR}	1.0	—	4.0	ns

11 I²C

This section describes the DC and AC electrical characteristics for the I²C interface of the MPC8323E.

11.1 I²C DC Electrical Characteristics

Table 33 provides the DC electrical characteristics for the I²C interface of the MPC8323E.

Table 33. I²C DC Electrical Characteristics

At recommended operating conditions with OV_{DD} of $3.3\text{ V} \pm 10\%$.

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage level	V_{IH}	$0.7 \times OV_{DD}$	$OV_{DD} + 0.3$	V	—
Input low voltage level	V_{IL}	-0.3	$0.3 \times OV_{DD}$	V	—
Low level output voltage	V_{OL}	0	0.4	V	1
Output fall time from $V_{IH}(\text{min})$ to $V_{IL}(\text{max})$ with a bus capacitance from 10 to 400 pF	t_{I2KLV}	$20 + 0.1 \times C_B$	250	ns	2
Pulse width of spikes which must be suppressed by the input filter	t_{I2KHL}	0	50	ns	3
Capacitance for each I/O pin	C_I	—	10	pF	—
Input current ($0\text{ V} \leq V_{IN} \leq OV_{DD}$)	I_{IN}	—	± 5	μA	4

Notes:

- Output voltage (open drain or open collector) condition = 3 mA sink current.
- C_B = capacitance of one bus line in pF.
- Refer to the *MPC8323E PowerQUICC II Pro Integrated Communications Processor Reference Manual* for information on the digital filter used.
- I/O pins obstructs the SDA and SCL lines if OV_{DD} is switched off.

11.2 I²C AC Electrical Specifications

Table 34 provides the AC timing parameters for the I²C interface of the MPC8323E.

Table 34. I²C AC Electrical Specifications

All values refer to $V_{IH}(\text{min})$ and $V_{IL}(\text{max})$ levels (see Table 33).

Parameter	Symbol ¹	Min	Max	Unit	
SCL clock frequency	f_{I2C}	0	400	kHz	
Low period of the SCL clock	t_{I2CL}	1.3	—	μs	
High period of the SCL clock	t_{I2CH}	0.6	—	μs	
Setup time for a repeated START condition	t_{I2SVKH}	0.6	—	μs	
Hold time (repeated) START condition (after this period, the first clock pulse is generated)	t_{I2SXKL}	0.6	—	μs	
Data setup time	t_{I2DVKH}	100	—	ns	
Data hold time:	CBUS compatible masters I ² C bus devices	t_{I2DXKL}	— 0^2	— 0.9^3	μs

Figure 31 and Figure 32 represent the AC timing from Table 45. Note that although the specifications generally reference the rising edge of the clock, these AC timing diagrams also apply when the falling edge is the active edge.

Figure 31 shows the SPI timing in slave mode (external clock).

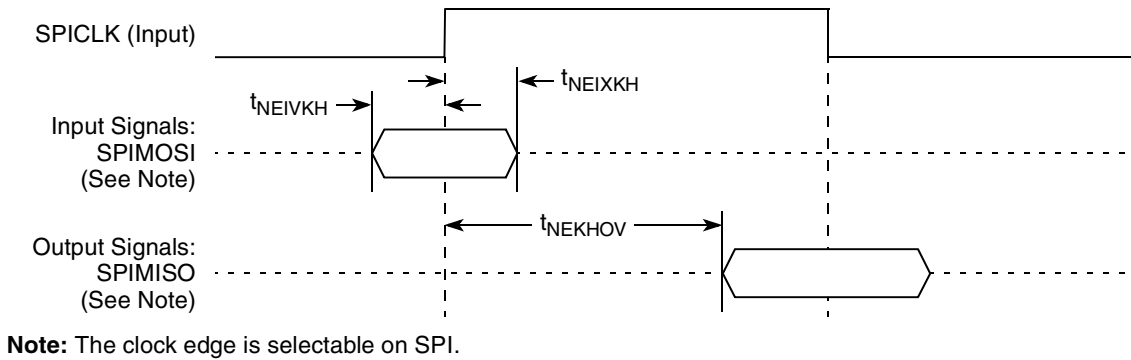


Figure 31. SPI AC Timing in Slave Mode (External Clock) Diagram

Figure 32 shows the SPI timing in master mode (internal clock).

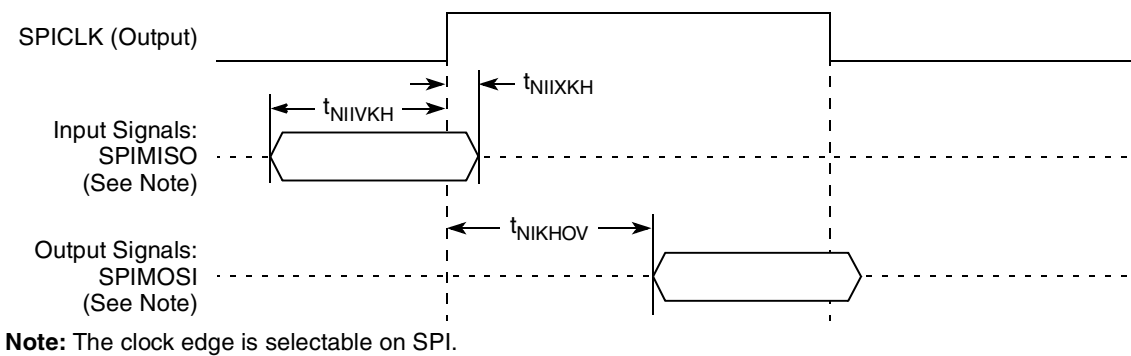


Figure 32. SPI AC Timing in Master Mode (Internal Clock) Diagram

17 TDM/SI

This section describes the DC and AC electrical specifications for the time-division-multiplexed and serial interface of the MPC8323E.

17.1 TDM/SI DC Electrical Characteristics

Table 46 provides the DC electrical characteristics for the MPC8323E TDM/SI.

Table 46. TDM/SI DC Electrical Characteristics

Characteristic	Symbol	Condition	Min	Max	Unit
Output high voltage	V_{OH}	$I_{OH} = -2.0 \text{ mA}$	2.4	—	V
Output low voltage	V_{OL}	$I_{OL} = 3.2 \text{ mA}$	—	0.5	V
Input high voltage	V_{IH}	—	2.0	$OV_{DD} + 0.3$	V

Table 46. TDM/SI DC Electrical Characteristics (continued)

Characteristic	Symbol	Condition	Min	Max	Unit
Input low voltage	V_{IL}	—	-0.3	0.8	V
Input current	I_{IN}	$0\text{ V} \leq V_{IN} \leq OV_{DD}$	—	± 5	μA

17.2 TDM/SI AC Timing Specifications

Table 47 provides the TDM/SI input and output AC timing specifications.

Table 47. TDM/SI AC Timing Specifications¹

Characteristic	Symbol ²	Min	Max	Unit
TDM/SI outputs—External clock delay	t_{SEKHOV}	2	12	ns
TDM/SI outputs—External clock High Impedance	t_{SEKHOX}	2	10	ns
TDM/SI inputs—External clock input setup time	t_{SEIVKH}	5	—	ns
TDM/SI inputs—External clock input hold time	t_{SEIXKH}	2	—	ns

Notes:

- Output specifications are measured from the 50% level of the rising edge of CLKIN to the 50% level of the signal. Timings are measured at the pin.
- The symbols used for timing specifications follow the pattern of $t_{(\text{first two letters of functional block})(\text{signal})(\text{state})(\text{reference})(\text{state})}$ for inputs and $t_{(\text{first two letters of functional block})(\text{reference})(\text{state})(\text{signal})(\text{state})}$ for outputs. For example, t_{SEKHOX} symbolizes the TDM/SI outputs external timing (SE) for the time $t_{TDM/SI}$ memory clock reference (K) goes from the high state (H) until outputs (O) are invalid (X).

Figure 33 provides the AC test load for the TDM/SI.

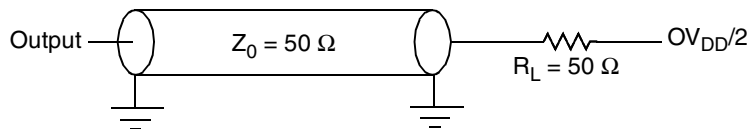
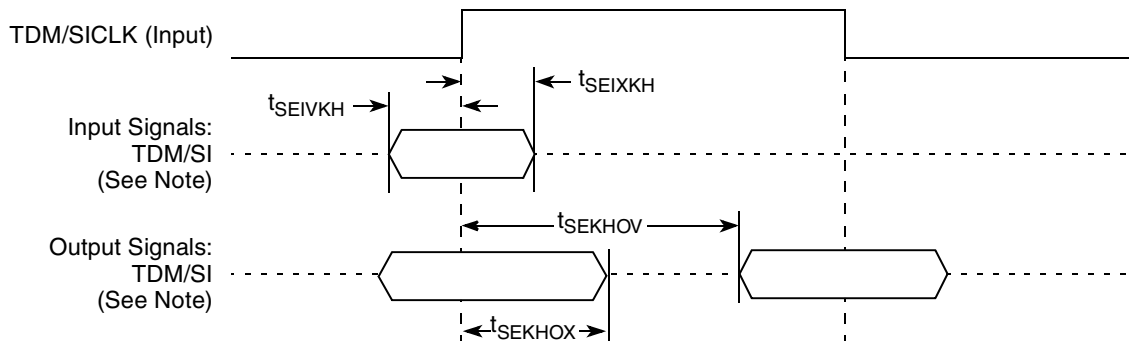


Figure 33. TDM/SI AC Test Load

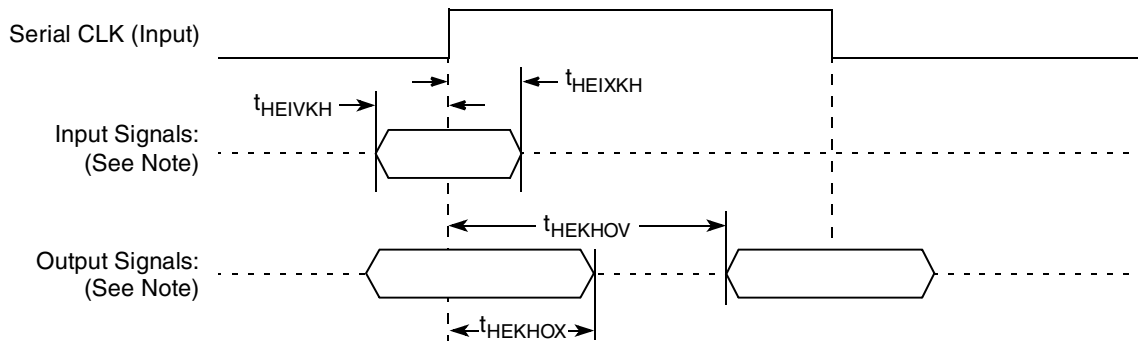
Figure 34 represents the AC timing from Table 47. Note that although the specifications generally reference the rising edge of the clock, these AC timing diagrams also apply when the falling edge is the active edge.



Note: The clock edge is selectable on TDM/SI.

Figure 34. TDM/SI AC Timing (External Clock) Diagram

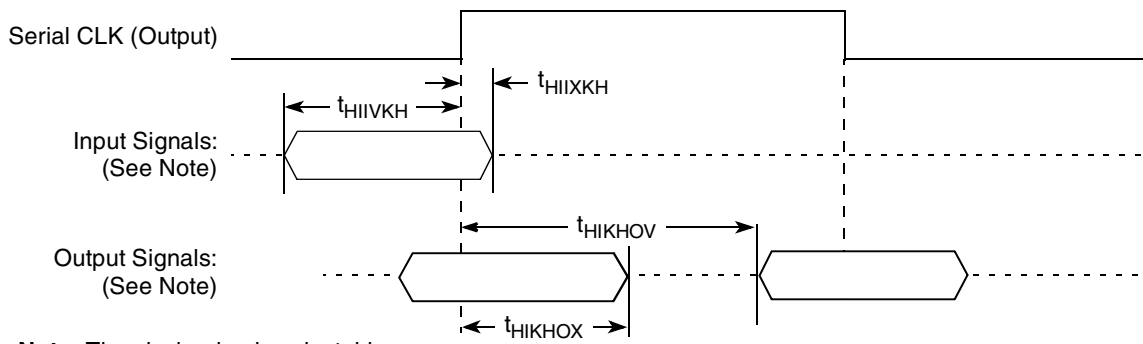
Figure 39 shows the timing with external clock.



Note: The clock edge is selectable.

Figure 39. AC Timing (External Clock) Diagram

Figure 40 shows the timing with internal clock.



Note: The clock edge is selectable.

Figure 40. AC Timing (Internal Clock) Diagram

20 USB

This section provides the AC and DC electrical specifications for the USB interface of the MPC8323E.

20.1 USB DC Electrical Characteristics

Table 53 provides the DC electrical characteristics for the USB interface.

Table 53. USB DC Electrical Characteristics¹

Parameter	Symbol	Min	Max	Unit
High-level input voltage	V_{IH}	2	$OV_{DD} + 0.3$	V
Low-level input voltage	V_{IL}	-0.3	0.8	V
High-level output voltage, $I_{OH} = -100 \mu A$	V_{OH}	$OV_{DD} - 0.2$	—	V
Low-level output voltage, $I_{OL} = 100 \mu A$	V_{OL}	—	0.2	V
Input current	I_{IN}	—	± 5	μA

Note:

- Note that the symbol V_{IN} , in this case, represents the OV_{IN} symbol referenced in Table 1 and Table 2.

20.2 USB AC Electrical Specifications

Table 54 describes the general timing parameters of the USB interface of the MPC8323E.

Table 54. USB General Timing Parameters

Parameter	Symbol ¹	Min	Max	Unit	Notes
USB clock cycle time	t_{USCK}	20.83	—	ns	Full speed 48 MHz
USB clock cycle time	t_{USCK}	166.67	—	ns	Low speed 6 MHz
Skew between TXP and TXN	t_{USTSPN}	—	5	ns	—
Skew among RXP, RXN, and RXD	$t_{USRSPND}$	—	10	ns	Full speed transitions
Skew among RXP, RXN, and RXD	t_{USRPND}	—	100	ns	Low speed transitions

Notes:

- The symbols used for timing specifications follow the pattern of $t_{(\text{first two letters of functional block})(\text{state})(\text{signal})}$ for receive signals and $t_{(\text{first two letters of functional block})(\text{state})(\text{signal})}$ for transmit signals. For example, $t_{USRSPND}$ symbolizes USB timing (US) for the USB receive signals skew (RS) among RXP, RXN, and RXD (PND). Also, t_{USTSPN} symbolizes USB timing (US) for the USB transmit signals skew (TS) between TXP and TXN (PN).
- Skew measurements are done at $OV_{DD}/2$ of the rising or falling edge of the signals.

Figure 41 provide the AC test load for the USB.

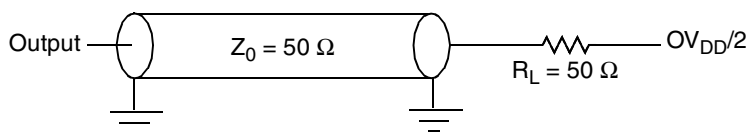


Figure 41. USB AC Test Load

21.3 Pinout Listings

Table 55 shows the pin list of the MPC8323E.

Table 55. MPC8323E PBGA Pinout Listing

Signal	Package Pin Number	Pin Type	Power Supply	Notes
DDR Memory Controller Interface				
MEMC_MDQ0	AE9	IO	GV _{DD}	—
MEMC_MDQ1	AD10	IO	GV _{DD}	—
MEMC_MDQ2	AF10	IO	GV _{DD}	—
MEMC_MDQ3	AF9	IO	GV _{DD}	—
MEMC_MDQ4	AF7	IO	GV _{DD}	—
MEMC_MDQ5	AE10	IO	GV _{DD}	—
MEMC_MDQ6	AD9	IO	GV _{DD}	—
MEMC_MDQ7	AF8	IO	GV _{DD}	—
MEMC_MDQ8	AE6	IO	GV _{DD}	—
MEMC_MDQ9	AD7	IO	GV _{DD}	—
MEMC_MDQ10	AF6	IO	GV _{DD}	—
MEMC_MDQ11	AC7	IO	GV _{DD}	—
MEMC_MDQ12	AD8	IO	GV _{DD}	—
MEMC_MDQ13	AE7	IO	GV _{DD}	—
MEMC_MDQ14	AD6	IO	GV _{DD}	—
MEMC_MDQ15	AF5	IO	GV _{DD}	—
MEMC_MDQ16	AD18	IO	GV _{DD}	—
MEMC_MDQ17	AE19	IO	GV _{DD}	—
MEMC_MDQ18	AF17	IO	GV _{DD}	—
MEMC_MDQ19	AF19	IO	GV _{DD}	—
MEMC_MDQ20	AF18	IO	GV _{DD}	—
MEMC_MDQ21	AE18	IO	GV _{DD}	—
MEMC_MDQ22	AF20	IO	GV _{DD}	—
MEMC_MDQ23	AD19	IO	GV _{DD}	—
MEMC_MDQ24	AD21	IO	GV _{DD}	—
MEMC_MDQ25	AF22	IO	GV _{DD}	—
MEMC_MDQ26	AC21	IO	GV _{DD}	—
MEMC_MDQ27	AF21	IO	GV _{DD}	—
MEMC_MDQ28	AE21	IO	GV _{DD}	—

Table 55. MPC8323E PBGA Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
MEMC_MDQ29	AD20	IO	GV _{DD}	—
MEMC_MDQ30	AF23	IO	GV _{DD}	—
MEMC_MDQ31	AD22	IO	GV _{DD}	—
MEMC_MDM0	AC9	O	GV _{DD}	—
MEMC_MDM1	AD5	O	GV _{DD}	—
MEMC_MDM2	AE20	O	GV _{DD}	—
MEMC_MDM3	AE22	O	GV _{DD}	—
MEMC_MDQS0	AE8	IO	GV _{DD}	—
MEMC_MDQS1	AE5	IO	GV _{DD}	—
MEMC_MDQS2	AC19	IO	GV _{DD}	—
MEMC_MDQS3	AE23	IO	GV _{DD}	—
MEMC_MBA0	AD16	O	GV _{DD}	—
MEMC_MBA1	AD17	O	GV _{DD}	—
MEMC_MBA2	AE17	O	GV _{DD}	—
MEMC_MA0	AD12	O	GV _{DD}	—
MEMC_MA1	AE12	O	GV _{DD}	—
MEMC_MA2	AF12	O	GV _{DD}	—
MEMC_MA3	AC13	O	GV _{DD}	—
MEMC_MA4	AD13	O	GV _{DD}	—
MEMC_MA5	AE13	O	GV _{DD}	—
MEMC_MA6	AF13	O	GV _{DD}	—
MEMC_MA7	AC15	O	GV _{DD}	—
MEMC_MA8	AD15	O	GV _{DD}	—
MEMC_MA9	AE15	O	GV _{DD}	—
MEMC_MA10	AF15	O	GV _{DD}	—
MEMC_MA11	AE16	O	GV _{DD}	—
MEMC_MA12	AF16	O	GV _{DD}	—
MEMC_MA13	AB16	O	GV _{DD}	—
MEMC_MWE	AC17	O	GV _{DD}	—
MEMC_MRAS	AE11	O	GV _{DD}	—
MEMC_MCAS	AD11	O	GV _{DD}	—
MEMC_MCS	AC11	O	GV _{DD}	—

Table 55. MPC8323E PBGA Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
CE/GPIO				
GPIO_PA0/SER1_TXD[0]/TDMA_TXD[0]/USBTXN	G3	IO	OV _{DD}	—
GPIO_PA1/SER1_TXD[1]/TDMA_TXD[1]/USBTXP	F3	IO	OV _{DD}	—
GPIO_PA2/SER1_TXD[2]/TDMA_TXD[2]	F2	IO	OV _{DD}	—
GPIO_PA3/SER1_TXD[3]/TDMA_TXD[3]	E3	IO	OV _{DD}	—
GPIO_PA4/SER1_RXD[0]/TDMA_RXD[0]/USBRXP	E2	IO	OV _{DD}	—
GPIO_PA5/SER1_RXD[1]/TDMA_RXD[1]/USBRXN	E1	IO	OV _{DD}	—
GPIO_PA6/SER1_RXD[2]/TDMA_RXD[2]/USBRXD	D3	IO	OV _{DD}	—
GPIO_PA7/SER1_RXD[3]/TDMA_RXD[3]	D2	IO	OV _{DD}	—
GPIO_PA8/SER1_CD/TDMA_REQ/USBOE	D1	IO	OV _{DD}	—
GPIO_PA9 TDMA_CLKO	C3	IO	OV _{DD}	—
GPIO_PA10/SER1_CTS/TDMA_RSYNC	C2	IO	OV _{DD}	—
GPIO_PA11/TDMA_STROBE	C1	IO	OV _{DD}	—
GPIO_PA12/SER1_RTS/TDMA_TSYNC	B1	IO	OV _{DD}	—
GPIO_PA13/CLK9/BRGO9	H4	IO	OV _{DD}	—
GPIO_PA14/CLK11/BRGO10	G4	IO	OV _{DD}	—
GPIO_PA15/BRGO7	J4	IO	OV _{DD}	—
GPIO_PA16/ LA0 (LBIU)	K24	IO	OV _{DD}	—
GPIO_PA17/ LA1 (LBIU)	K26	IO	OV _{DD}	—
GPIO_PA18/Enet2_TXD[0]/SER2_TXD[0]/ TDMB_TXD[0]/LA2 (LBIU)	G25	IO	OV _{DD}	—
GPIO_PA19/Enet2_TXD[1]/SER2_TXD[1]/ TDMB_TXD[1]/LA3 (LBIU)	G26	IO	OV _{DD}	—
GPIO_PA20/Enet2_TXD[2]/SER2_TXD[2]/ TDMB_TXD[2]/LA4 (LBIU)	H25	IO	OV _{DD}	—
GPIO_PA21/Enet2_TXD[3]/SER2_TXD[3]/ TDMB_TXD[3]/LA5 (LBIU)	H26	IO	OV _{DD}	—
GPIO_PA22/Enet2_RXD[0]/SER2_RXD[0]/ TDMB_RXD[0]/LA6 (LBIU)	C25	IO	OV _{DD}	—
GPIO_PA23/Enet2_RXD[1]/SER2_RXD[1]/ TDMB_RXD[1]/LA7 (LBIU)	C26	IO	OV _{DD}	—
GPIO_PA24/Enet2_RXD[2]/SER2_RXD[2]/ TDMB_RXD[2]/LA8 (LBIU)	D25	IO	OV _{DD}	—
GPIO_PA25/Enet2_RXD[3]/SER2_RXD[3]/ TDMB_RXD[3]/LA9 (LBIU)	D26	IO	OV _{DD}	—

Table 55. MPC8323E PBGA Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
GPIO_PD10/GTM1_TIN2/GTM2_TIN1/CLK17	J24	IO	OV _{DD}	—
GPIO_PD11/ $\overline{\text{GTM1_TGATE2}}$ / $\overline{\text{GTM2_TGATE1}}$	B25	IO	OV _{DD}	—
GPIO_PD12/ $\overline{\text{GTM1_TOUT2}}$ / $\overline{\text{GTM2_TOUT1}}$	C4	IO	OV _{DD}	—
GPIO_PD13/GTM1_TIN3/GTM2_TIN4/BRGO8	D4	IO	OV _{DD}	—
GPIO_PD14/ $\overline{\text{GTM1_TGATE3}}$ / $\overline{\text{GTM2_TGATE4}}$	D5	IO	OV _{DD}	—
GPIO_PD15/ $\overline{\text{GTM1_TOUT3}}$	A5	IO	OV _{DD}	—
GPIO_PD16/GTM1_TIN4/GTM2_TIN3	B5	IO	OV _{DD}	—
GPIO_PD17/ $\overline{\text{GTM1_TGATE4}}$ / $\overline{\text{GTM2_TGATE3}}$	C5	IO	OV _{DD}	—
GPIO_PD18/ $\overline{\text{GTM1_TOUT4}}$ / $\overline{\text{GTM2_TOUT3}}$	A6	IO	OV _{DD}	—
GPIO_PD19/CE_RISC1_INT/CE_EXT_REQ4	B6	IO	OV _{DD}	—
GPIO_PD20/CLK18/BRGO6	D21	IO	OV _{DD}	—
GPIO_PD21/CLK16/BRGO5/UPC1_CLKO	C19	IO	OV _{DD}	—
GPIO_PD22/CLK4/BRGO9/UCC2_CLKO	A7	IO	OV _{DD}	—
GPIO_PD23/CLK3/BRGO10/UCC3_CLKO	B7	IO	OV _{DD}	—
GPIO_PD24/CLK10/BRGO2/UCC4_CLKO	A12	IO	OV _{DD}	—
GPIO_PD25/CLK13/BRGO16/UCC5_CLKO	B10	IO	OV _{DD}	—
GPIO_PD26/CLK2/BRGO4/UCC1_CLKO	E4	IO	OV _{DD}	—
GPIO_PD27/CLK1/BRGO3	F4	IO	OV _{DD}	—
GPIO_PD28/CLK19/BRGO11	D15	IO	OV _{DD}	—
GPIO_PD29/CLK15/BRGO8	C6	IO	OV _{DD}	—
GPIO_PD30/CLK14	D6	IO	OV _{DD}	—
GPIO_PD31/CLK7/BRGO15	E24	IO	OV _{DD}	—
Power and Ground Supplies				
GV _{DD}	AA8, AA10, AA11, AA13, AA14, AA16, AA17, AA19, AA21, AB9, AB10, AB11, AB12, AB14, AB18, AB20, AB21, AC6, AC8, AC14, AC18	GV _{DD}	—	—
OV _{DD}	E5, E6, E8, E9, E10, E12, E14, E15, E16, E18, E19, E20, E22, F5, F6, F8, F10, F14, F16, F19, F22, G22, H5, H6, H21, J5, J22, K21, K22, L5, L6, L22, M5, M22, N5, N21, N22, P6, P22, P23, R5, R23, T5, T21, T22, U6, U22, V5, V22, W22, Y5, AB5, AB6, AC5	OV _{DD}	—	—

Table 55. MPC8323E PBGA Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
V_{DD}	K10, K11, K12, K13, K14, K15, K16, K17, L10, L17, M10, M17, N10, N17, P10, P17, R10, R17, T10, T17, U10, U11, U12, U13, U14, U15, U16, U17	V_{DD}	—	—
V_{SS}	B23, E7, E11, E13, E17, E21, F11, F13, F17, F21, F23, G5, H22, K5, K6, L11, L12, L13, L14, L15, L16, L21, M11, M12, M13, M14, M15, M16, N6, N11, N12, N13, N14, N15, N16, P5, P11, P12, P13, P14, P15, P16, P21, R11, R12, R13, R14, R15, R16, R22, T6, T11, T12, T13, T14, T15, T16, U5, U21, V23, W5, W6, W21, W23, W24, Y22, AA5, AA6, AA22, AA25, AB7, AB13, AB19, AB22, AC10, AC12, AC16, AC20	V_{SS}	—	—
No Connect				
NC	C22	—	—	—

Notes:

1. This pin is an open drain signal. A weak pull-up resistor (1 k Ω) should be placed on this pin to OV_{DD} .
2. This pin is an open drain signal. A weak pull-up resistor (2–10 k Ω) should be placed on this pin to OV_{DD} .
3. This output is actively driven during reset rather than being three-stated during reset.
4. These JTAG and local bus pins have weak internal pull-up P-FETs that are always enabled.
5. This pin should have a weak pull up if the chip is in PCI host mode. Follow the PCI specification's recommendation.
6. This pin must always be tied to GND. 7. This pin has weak internal pull-down N-FET that is always enabled. 8. Though this pin has weak internal pull-up yet it is recommended to apply an external pull-up.

22 Clocking

Figure 43 shows the internal distribution of clocks within the MPC8323E.

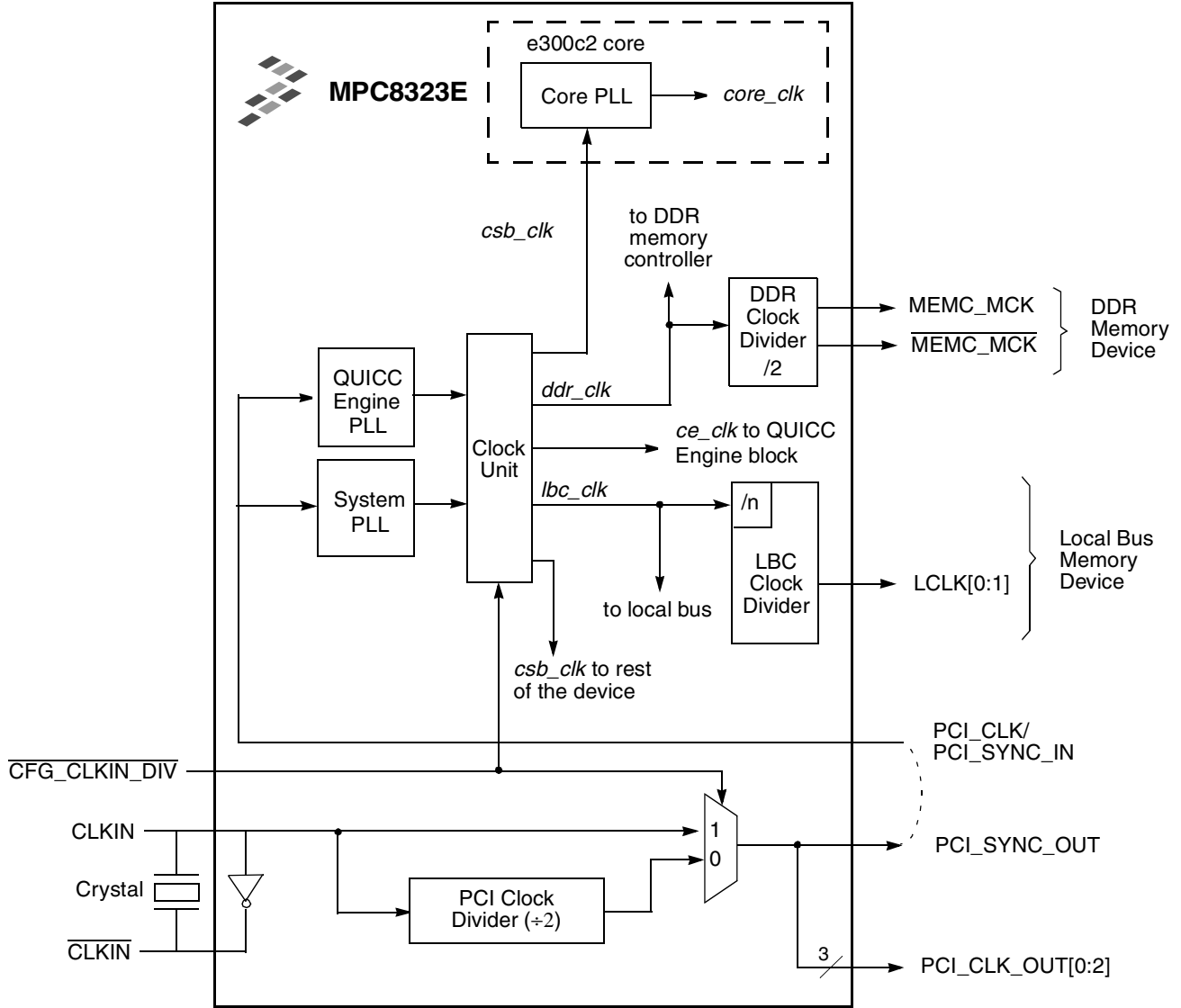


Figure 43. MPC8323E Clock Subsystem

The primary clock source for the MPC8323E can be one of two inputs, CLKIN or PCI_CLK, depending on whether the device is configured in PCI host or PCI agent mode, respectively.

Table 57. Operating Frequencies for PBGA (continued)

Characteristic ¹	Max Operating Frequency	Unit
DDR1/DDR2 memory bus frequency (MCLK) ²	133	MHz
Local bus frequency (LCLK _n) ³	66	MHz
PCI input frequency (CLKIN or PCI_CLK)	66	MHz

¹ The CLKIN frequency, RCWL[SPMF], and RCWL[COREPLL] settings must be chosen such that the resulting *csb_clk*, MCLK, LCLK[0:2], and *core_clk* frequencies do not exceed their respective maximum or minimum operating frequencies.

² The DDR1/DDR2 data rate is 2x the DDR1/DDR2 memory bus frequency.

³ The local bus frequency is 1/2, 1/4, or 1/8 of the *lb_clk* frequency (depending on LCRR[CLKDIV]) which is in turn 1x or 2x the *csb_clk* frequency (depending on RCWL[LBCM]).

22.4 System PLL Configuration

The system PLL is controlled by the RCWL[SPMF] parameter. [Table 58](#) shows the multiplication factor encodings for the system PLL.

NOTE

System PLL VCO frequency = 2 × (CSB frequency) × (System PLL VCO divider).

The VCO divider needs to be set properly so that the System PLL VCO frequency is in the range of 300–600 MHz.

Table 58. System PLL Multiplication Factors

RCWL[SPMF]	System PLL Multiplication Factor
0000	Reserved
0001	Reserved
0010	× 2
0011	× 3
0100	× 4
0101	× 5
0110	× 6
0111–1111	Reserved

As described in [Section 22, “Clocking,”](#) the LBCM, DDRCM, and SPMF parameters in the reset configuration word low and the CFG_CLKIN_DIV configuration input signal select the ratio between the primary clock input (CLKIN or PCI_CLK) and the internal coherent system bus clock (*csb_clk*). [Table 59](#)

shows the expected frequency values for the CSB frequency for select *csb_clk* to CLKIN/PCI_SYNC_IN ratios.

Table 59. CSB Frequency Options

CFG_CLKIN_DIV_B at Reset ¹	SPMF	<i>csb_clk</i> : Input Clock Ratio ²	Input Clock Frequency (MHz) ²		
			25	33.33	66.67
			<i>csb_clk</i> Frequency (MHz)		
High	0010	2 : 1			133
High	0011	3 : 1		100	
High	0100	4 : 1	100	133	
High	0101	5 : 1	125		
High	0110	6 : 1			
High	0111	7 : 1			
High	1000	8 : 1			
High	1001	9 : 1			
High	1010	10 : 1			
High	1011	11 : 1			
High	1100	12 : 1			
High	1101	13 : 1			
High	1110	14 : 1			
High	1111	15 : 1			
High	0000	16 : 1			
Low	0010	2 : 1			133
Low	0011	3 : 1		100	
Low	0100	4 : 1		133	
Low	0101	5 : 1			
Low	0110	6 : 1			
Low	0111	7 : 1			
Low	1000	8 : 1			
Low	1001	9 : 1			
Low	1010	10 : 1			
Low	1011	11 : 1			
Low	1100	12 : 1			
Low	1101	13 : 1			
Low	1110	14 : 1			
Low	1111	15 : 1			
Low	0000	16 : 1			

¹ CFG_CLKIN_DIV_B is only used for host mode; CLKIN must be tied low and CFG_CLKIN_DIV_B must be pulled up (high) in agent mode.

² CLKIN is the input clock in host mode; PCI_CLK is the input clock in agent mode.

22.7 Suggested PLL Configurations

To simplify the PLL configurations, the MPC8323E might be separated into two clock domains. The first domain contain the CSB PLL and the core PLL. The core PLL is connected serially to the CSB PLL, and has the `csb_clk` as its input clock. The second clock domain has the QUICC Engine PLL. The clock domains are independent, and each of their PLLs are configured separately. Both of the domains has one common input clock. [Table 63](#) shows suggested PLL configurations for 33, 25, and 66 MHz input clocks.

Table 63. Suggested PLL Configurations

Conf No.	SPMF	Core PLL	CEMF	CEDF	Input Clock Frequency (MHz)	CSB Frequency (MHz)	Core Frequency (MHz)	QUICC Engine Frequency (MHz)
1	0100	0000100	0110	0	33.33	133.33	266.66	200
2	0100	0000101	1000	0	25	100	250	200
3	0010	0000100	0011	0	66.67	133.33	266.66	200
4	0100	0000101	0110	0	33.33	133.33	333.33	200
5	0101	0000101	1000	0	25	125	312.5	200
6	0010	0000101	0011	0	66.67	133.33	333.33	200

23 Thermal

This section describes the thermal specifications of the MPC8323E.

23.1 Thermal Characteristics

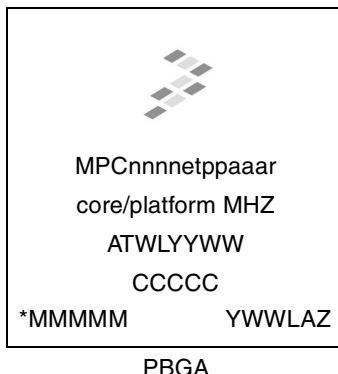
[Table 64](#) provides the package thermal characteristics for the 516 27 × 27 mm PBGA of the MPC8323E.

Table 64. Package Thermal Characteristics for PBGA

Characteristic	Board type	Symbol	Value	Unit	Notes
Junction-to-ambient natural convection	Single-layer board (1s)	$R_{\theta JA}$	28	°C/W	1, 2
Junction-to-ambient natural convection	Four-layer board (2s2p)	$R_{\theta JA}$	21	°C/W	1, 2, 3
Junction-to-ambient (@200 ft/min)	Single-layer board (1s)	$R_{\theta JMA}$	23	°C/W	1, 3
Junction-to-ambient (@200 ft/min)	Four-layer board (2s2p)	$R_{\theta JMA}$	18	°C/W	1, 3
Junction-to-board	—	$R_{\theta JB}$	13	°C/W	4
Junction-to-case	—	$R_{\theta JC}$	9	°C/W	5

25.2 Part Marking

Parts are marked as in the example shown in [Figure 46](#).



Notes:

- ATWLYYWW is the traceability code.
- CCCCC is the country code.
- MMMMM is the mask number.
- YWWLAZ is the assembly traceability code.

Figure 46. Freescale Part Marking for PBGA Devices

26 Document Revision History

[Table 67](#) provides a revision history for this hardware specification.

Table 67. Document Revision History

Rev. No.	Date	Substantive Change(s)
4	09/2010	<ul style="list-style-type: none"> • Replaced all instances of “LCCR” with “LCRR” throughout. • Added footnotes 3 and 4 in Table 2, “Recommended Operating Conditions³.” • Modified Section 8.1.1, “DC Electrical Characteristics.” • Modified Table 23, “MII Transmit AC Timing Specifications.” • Modified Table 24, “MII Receive AC Timing Specifications.” • Added footnote 7 and 8, and modified some signal names in Table 55, “MPC8323E PBGA Pinout Listing.”
3	12/2009	<ul style="list-style-type: none"> • Removed references for note 4 from Table 1. • Added Figure 2 in Section 2.1.2, “Power Supply Voltage Specification. • Added symbol T_A in Table 2. • Added footnote 2 in Table 2. • Added a note in Section 4, “Clock Input Timing for rise/fall time of QE input pins. • Modified CLKIN, PCI_CLK rise/fall time parameters in Table 8. Modified min value of t_{MCK} in Table 19. • Modified Figure 43. • Modified formula for ce_clk calculation in Section 22.3, “System Clock Domains. • Added a note in Section 22.4, “System PLL Configuration. • Removed the signal ECID_TMODE_IN from Table 55. • Removed all references of RST signals from Table 55.